

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

ATTY DOCKET NO. 03500.017974

APPLICATION NO. 10/807,304

APPLICANT Toshimitsu KARIYA

Date Submitted: August 31, 2004			FILING DATE March 24, 2004		GROUP 1753		
			U.S. PATENT DOCUMENTS				
'EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
/JB/	US-6,177,711 B1	01/23/2001	Kariya	257	458		
	US-6,215,061 B1	04/10/2001	Kariya	136	256		
	US-6,344,608 B2	02/05/2002	Kariya et al.	136	257		
	US-6,123,824	09/26/2000	Sano et al.	205	124		
	US-5,510,151	04/23/1996	Matsuyama et al.	427	509		
	US-5,714,010	02/03/1998	Matsuyama et al.	118	723 MW		
	US-6,472,248 B2	10/29/2002	Shiozaki et al.	438	97		
	US-6,399,873 B1	06/04/2002	Sano et al.	136	249		
	US-6,103,138	08/15/2000	Kondo	252	62.3 E		
	US-6,238,808 B1	05/29/2001	Arao et al.	428	629		
l	US-6,215,061 B1	04/10/2001	Kariya	136	256		
/JB/	US-6,222,117 B1	04/24/2001	Shiozaki	136	256		
		FOR	REIGN PATENT DOCUMENTS				
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATIO YES/NO/ OR ABSTRAC	
/JB/	11-251610	09/17/1999	Japan			Abstract	
/JB/	11-310495	11/09/1999	Japan			Abstract	
/JB/	11-317538	11/16/1999	Japan			Abstract	
	ОТ	HER DOCUMENT(S)	(Including Author, Title, Date, Pertinent Pages, Etc.)				
/JB/	Meier, J., et al., "ON THE WAY TOWARDS HIGH EFFICIENTY THIN FILM SILICON SOLAR CELLS BY THE "MICROMORPH" CONCEPT," <i>Materials Research Society Symposium Proceedings</i> , Volume 420, Amorphous Silicon Technology - 1996, April 8-12, 1996, San Francisco, CA. Pp. 3-14.						
EXAMINER	/Jeffrey Barton/		DATE CONSIDERED 12/21/2007				

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

		AUG J							
FORM PTO 1449 (Y		TTY DOCKET NO. 03500.017974	APPLIC	APPLICATION NO. 10/807,304				
ll .	S. DEPARTMENT OF COMMENT ATENT AND TRADEMARK OFFICE REFERENCES CITED BY APPLI (Use several sheets if necessary)	ICANT(S)	PPLICANT TOShimitsu KARIYA						
Dat	te Submitted: August 31, 2		ILING DATE March 24, 2004		GROUP 1753				
	U.S. PATENT DOCUMENTS								
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLAS	s SUBCLASS	FILING DATE			
						-			
		FOREI	GN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLAS	S SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT			
/JB/	11-243218	09/07/1999	Japan			Abstract			
/JB/	2000-22189	01/21/2000	Japan			Abstract			
		 							
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)									
Yamamoto, Kenji, et al. "Optical Confinement Effect for below 5 μm Thin Film Poly-Si Solar Cell on Glass Substrate," <i>Japanese Journal of Applied Physics</i> , Part 2, Letters, Vol. 36, No. 5A, May 1, 1997. Pp. L569-L572.									
EXAMINER	/Jeffrey Barton/		DATE CONSIDERED 12/21/2007	,					

Sheet 2 of 2

^{*}EXAMINER: Initial If reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

			-3/	T			
FURM PTO 1449 (modified) SEP 2 2 2004			10 TH)	ATTY DOCKET NO. 03500.017974	APPLICATION NO. 10/807,304		
		EPARTMENT OF COMME T AND TRADEMARK OFF		APPLICANT			
LIS	T OF REF	ERENCES CITED EN ALS	CANT(S)	Toshimitsu KARIYA			
		se several sheets if necessary))	FILING DATE	GROUP		
Date submitted to	PTO: Sep	tember 22, 2004		March 24, 2004		1/	753
ļ		1		U.S. PATENT DOCUMENTS			
*EXAMINER INITIAL	<u> </u>	DOCUMENT NUMBER	DATE '	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
							
		1	F(OREIGN PATENT DOCUMENTS			
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
					+		
	, !				+		
						+	
		1	OTHER DOCUMENT	(S) (Including Author, Title, Date, Pertinent Pages, Etc.)			
/JB/		Fabricated at Lo	ow Temperature'	ilm Poly-Si Solar Cell with 'Star Struct ", 26 th Photovoltaic Specialists Conferer			
	-	IEEE, pp. 575-5	80.			<u></u>	
							- A
	·						
EXAMINER	/Jr	effrey Barton/		DATE CONSIDERED 12/21/2007			

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.